

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/542,616 AASTRUP ET AL.	
		Examiner	Art Unit JOHN FITZGERALD	2856 Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,552,274 A	09-1996	Oyama et al.	435/6
*	B	US-6,106,149 A	08-2000	Smith, Allan L.	374/31
*	C	US-6,189,367 B1	02-2001	Smith et al.	73/19.03
*	D	US-6,190,035 B1	02-2001	Smith, Allan L.	374/31
*	E	US-6,295,861 B1	10-2001	Tom et al.	73/24.06
*	F	US-6,370,939 B2	04-2002	Smith et al.	73/19.03
*	G	US-2009/0151428 A1	06-2009	Bhethanabotla et al.	73/24.06
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Josse et al., "Analysis of the Radial Dependence of Mass Sensitivity for Modified-Electrode Quartz Crystal Resonators," Jan. 15, 1998, Analytical Chemistry, Vol. 70, No. 2, ppgs 237-247
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.